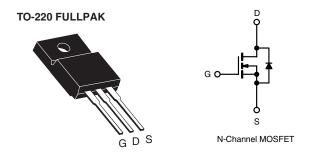


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	60			
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.20		
Q _g (Max.) (nC)	11			
Q _{gs} (nC)	3.1			
Q _{gd} (nC)	5.8			
Configuration	Single			



FEATURES

- · Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)



- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- · Dynamic dv/dt Rating
- Low Thermal Resistance
- · Lead (Pb)-free Available

DESCRIPTION

Third deneration Power MOSFETs from Vishay provides the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost effectiveness.

The TO-220 Fullpak eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The Fullpak is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION		
Package	TO-220 FULLPAK	
Lead (Pb)-free	IRFIZ14GPbF	
	SiHFIZ14G-E3	
SnPb	IRFIZ14G	
	SiHFIZ14G	

PARAMETER			SYMBOL	LIMIT	UNIT	
Gate-Source Voltage			V_{GS}	± 20	V	
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C	- I _D	8.0	А	
		T _C = 100 °C		5.7		
Pulsed Drain Current ^a			I _{DM}	32		
Linear Derating Factor				0.18	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	47	mJ	
Maximum Power Dissipation	T _C = 25 °C		P_{D}	27	W	
Peak Diode Recovery dV/dt ^c			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	°C		
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d]	
Mounting Torque	6 22 or N	C 00 av M0 aavav		10	lbf ⋅ in	
	6-32 or M3 screw			1.1	N · m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 856 mH, R_G = 25 Ω , I_{AS} = 8.0 A (see fig. 12).
- c. $I_{SD} \le 10$ A, $dI/dt \le 90$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFIZ14G, SiHFIZ14G

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	5.5	C/VV	

PARAMETER	SYMBOL	TEST (TEST CONDITIONS		TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60	-	-	٧
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I _D = 1 mA		0.63	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$		2.0	-	4.0	٧
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 20		-	-	± 100	nA
Zero Gate Voltage Drain Current	lana	V _{DS} = 60 V, V _{GS} = 0 V		ı	-	25	μΑ
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 48 V, V	V _{DS} = 48 V, V _{GS} = 0 V, T _J = 150 °C		-	250	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 4.8 A ^b	1	-	0.20	Ω
Forward Transconductance	9 _{fs}	V _{DS} = 25 V, I _D = 4.8 A ^b		2.2	-	-	S
Dynamic							
Input Capacitance	C _{iss}	V _{GS} = 0 V		-	300	-	- pF
Output Capacitance	C_{oss}	$V_{DS} = 25 \text{ V}$		i	160	-	
Reverse Transfer Capacitance	C_{rss}	f = 1.0 MHz, see fig. 5		ı	29	-	
Drain to Sink Capacitance	С	f =	= 1.0 MHz	ī	12	-	
Total Gate Charge	Q_g			ı	-	11	nC
Gate-Source Charge	Q_{gs}	V _{GS} = 10 V	$I_D = 10 \text{ A}, V_{DS} = 48 \text{ V},$ see fig. 6 and 13 ^b	-	-	3.1	
Gate-Drain Charge	Q_{gd}		see lig. 6 and 13°	-	-	5.8	
Turn-On Delay Time	t _{d(on)}	$V_{DD}=30~V,~I_D=10~A$ $R_G=24~\Omega,~R_D=2.7~\Omega,~see~fig.~10^b$		-	10	-	- ns
Rise Time	t _r			-	50	-	
Turn-Off Delay Time	t _{d(off)}			-	13	-	
Fall Time	t _f			ī	19	-	
Internal Drain Inductance	L_D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	mll
Internal Source Inductance	L _S			-	7.5	-	nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		ı	-	8.0	- A
Pulsed Diode Forward Current ^a	I _{SM}			ı	-	32	
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, \ I_S = 8.0 \text{A}, \ V_{GS} = 0 \text{V}^{\text{b}}$		-	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}	- T _J = 25 °C, I _F = 10 A, di/dt = 100 A/μs ^b		-	70	140	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.20	0.40	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-	on is dor	minated b	y L _S and	L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

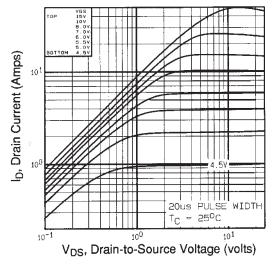


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

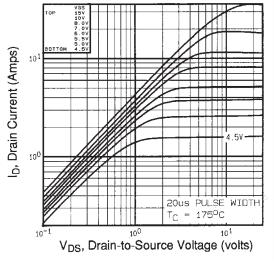


Fig. 2 - Typical Output Characteristics, $T_C = 175$ °C

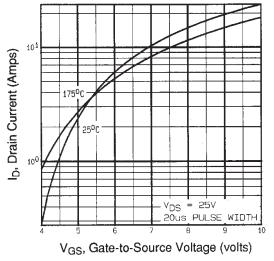


Fig. 3 - Typical Transfer Characteristics

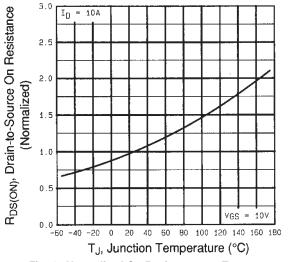


Fig. 4 - Normalized On-Resistance vs. Temperature

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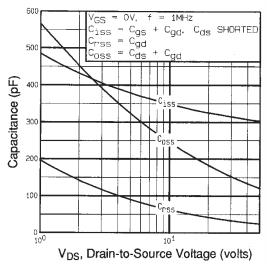


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

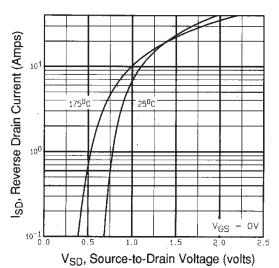


Fig. 7 - Typical Source-Drain Diode Forward Voltage

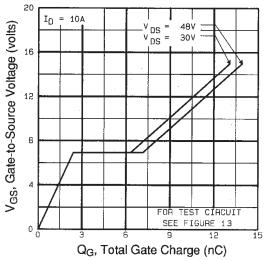


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

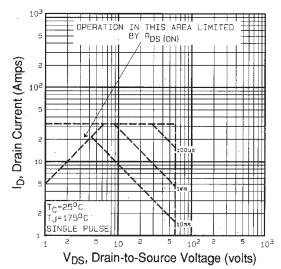


Fig. 8 - Maximum Safe Operating Area





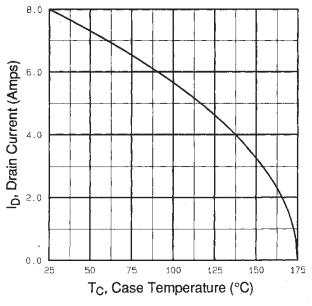


Fig. 9 - Maximum Drain Current vs. Case Temperature

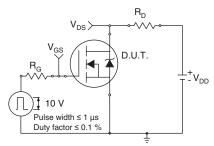


Fig. 10a - Switching Time Test Circuit

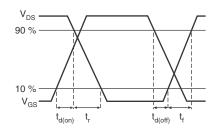


Fig. 10b - Switching Time Waveforms

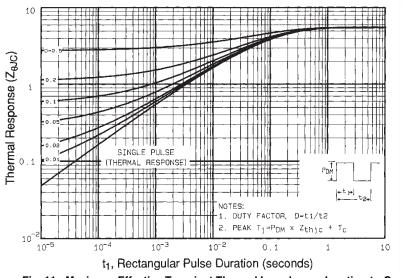


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

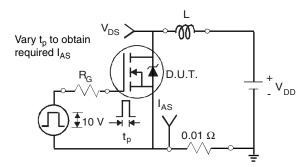


Fig. 12a - Unclamped Inductive Test Circuit

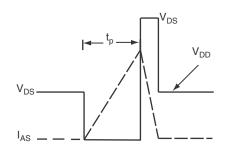


Fig. 12b - Unclamped Inductive Waveforms

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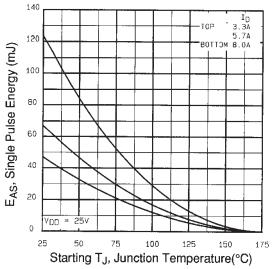


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

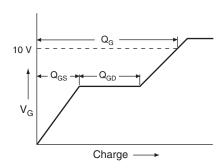


Fig. 13a - Basic Gate Charge Waveform

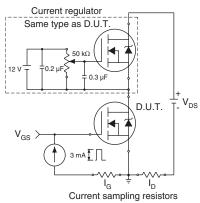
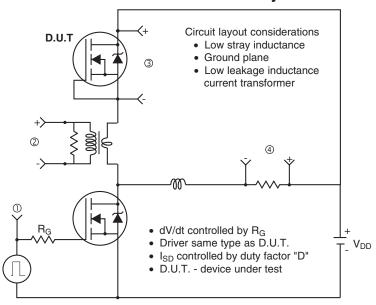
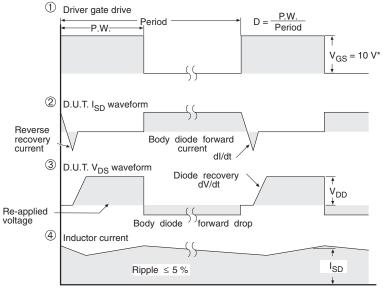


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





* V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel

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